

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSII)

TPC6101

Notebook PC Applications

Portable Equipment Applications

Unit: mm

- Low drain-source ON resistance: $R_{DS(ON)} = 48 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 8.2 \text{ S}$ (typ.)
- Low leakage current: $ID_{SS} = -10 \text{ }\mu\text{A}$ (max) ($V_{DS} = -20 \text{ V}$)
- Enhancement-model: $V_{th} = -0.5$ to -1.2 V ($V_{DS} = -10 \text{ V}$,
 $ID = -200 \text{ }\mu\text{A}$)

Maximum Ratings (Ta = 25°C)

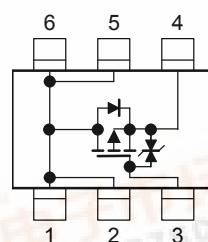
Characteristics	Symbol	Rating	Unit
Drain-source voltage	V_{DSS}	-20	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	V_{DGR}	-20	V
Gate-source voltage	V_{GSS}	± 12	V
Drain current	DC (Note 1)	I_D	-4.5
	Pulse (Note 1)	I_{DP}	-18
Drain power dissipation ($t = 5 \text{ s}$) (Note 2a)	P_D	2.2	W
Drain power dissipation ($t = 5 \text{ s}$) (Note 2b)	P_D	0.7	W
Single pulse avalanche energy (Note 3)	E_{AS}	3.3	mJ
Avalanche current	I_{AR}	-2.25	A
Repetitive avalanche energy (Note 4)	E_{AR}	0.22	mJ
Channel temperature	T_{ch}	150	°C
Storage temperature range	T_{stg}	-55 to 150	°C

The drawing illustrates the top view of a TOSIBA 2-3T1A MOSFET. It features a central rectangular body with four vertical metal leads. Lead 6 is the drain lead, located at the top. Lead 4 is the source lead, located at the bottom. Lead 3 is the gate lead, located on the left. Lead 1 is the drain lead, located on the right. The top lead 6 is labeled with a dimension of $0.3+0.1$. The distance between the center of lead 6 and the center of lead 4 is $1.6-0.1$. The distance between the center of lead 6 and the center of lead 3 is $1.6+0.2$. The distance between the center of lead 4 and the center of lead 1 is $2.8-0.3$. The distance between the center of lead 3 and the center of lead 1 is $0.95-0.95$. The distance between the center of lead 4 and the center of lead 3 is $0.7+0.05$. The distance between the center of lead 6 and the center of lead 1 is $2.9+0.2$. The distance between the center of lead 6 and the center of lead 3 is $0.05+0.05$. The distance between the center of lead 4 and the center of lead 1 is $0.05+0.05$. The distance between the center of lead 4 and the center of lead 3 is $0.16+0.05$. The distance between the center of lead 6 and the center of lead 4 is $+0.25$. The distance between the center of lead 6 and the center of lead 3 is $0.25-0.15$.

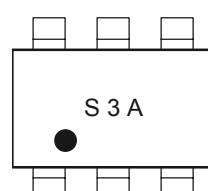
1. Drain 4. Source
 2. Drain 5. Drain
 3. Gate 6. Drain

Weight: 0.011 g (typ.)

Circuit Configuration



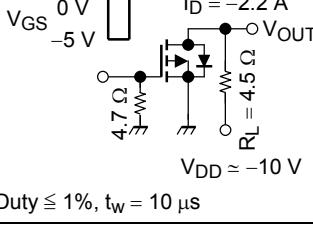
Marking (Note 5)



Note: (Note 1), (Note 2), (Note 3), (Note 4), (Note 5) Please see next page

This transistor is an electrostatically sensitive device. Please handle it with caution.

Electrical Characteristics ($T_a = 25^\circ\text{C}$)

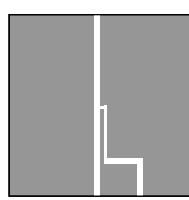
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current	I_{GSS}	$V_{GS} = \pm 10\text{ V}, V_{DS} = 0\text{ V}$	—	—	± 10	μA
Drain cut-OFF current	I_{DSS}	$V_{DS} = -20\text{ V}, V_{GS} = 0\text{ V}$	—	—	-10	μA
Drain-source breakdown voltage	$V_{(BR)DSS}$	$I_D = -10\text{ mA}, V_{GS} = 0\text{ V}$	-20	—	—	V
	$V_{(BR)DSX}$	$I_D = -10\text{ mA}, V_{GS} = 12\text{ V}$	-8	—	—	
Gate threshold voltage	V_{th}	$V_{DS} = -10\text{ V}, I_D = -200\text{ }\mu\text{A}$	-0.5	—	-1.2	V
Drain-source ON resistance	$R_{DS}(\text{ON})$	$V_{GS} = -2\text{ V}, I_D = -2.2\text{ A}$	—	110	180	$\text{m}\Omega$
	$R_{DS}(\text{ON})$	$V_{GS} = -2.5\text{ V}, I_D = -2.2\text{ A}$	—	75	100	
	$R_{DS}(\text{ON})$	$V_{GS} = -4.5\text{ V}, I_D = -2.2\text{ A}$	—	48	60	
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = -10\text{ V}, I_D = -2.2\text{ A}$	4.1	8.2	—	S
Input capacitance	C_{iss}	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	—	830	—	pF
Reverse transfer capacitance	C_{rss}		—	300	—	
Output capacitance	C_{oss}		—	370	—	
Switching time	Rise time	t_r		—	6	—
	Turn-ON time	t_{on}		—	11	—
	Fall time	t_f		—	57	—
	Turn-OFF time	t_{off}		—	112	—
Total gate charge (gate-source plus gate-drain)	Q_g	$V_{DD} \approx -16\text{ V}, V_{GS} = -5\text{ V}, I_D = -4.5\text{ A}$	—	12	—	nC
Gate-source charge	Q_{gs}		—	6	—	
Gate-drain ("miller") charge	Q_{gd}		—	6	—	

Source-Drain Ratings and Characteristics ($T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Pulse drain reverse current (Note 1)	I_{DRP}	—	—	—	-18	A
Forward voltage (diode)	V_{DSF}	$I_{DR} = -4.5\text{ A}, V_{GS} = 0\text{ V}$	—	—	1.2	V

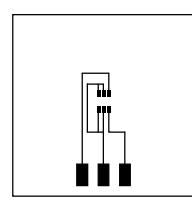
Note 1: Please use devices on condition that the channel temperature is below 150°C .

Note 2: (a) Device mounted on a glass-epoxy board (a) ($t = 5\text{ s}$)
 (b) Device mounted on a glass-epoxy board (b) ($t = 5\text{ s}$)



FR-4
 $25.4 \times 25.4 \times 0.8$
 Unit: (mm)

(a)



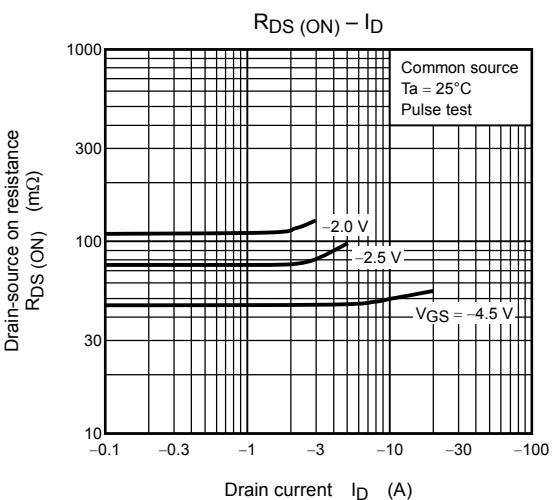
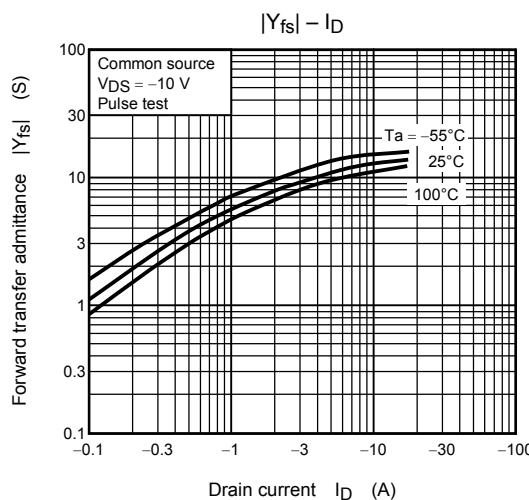
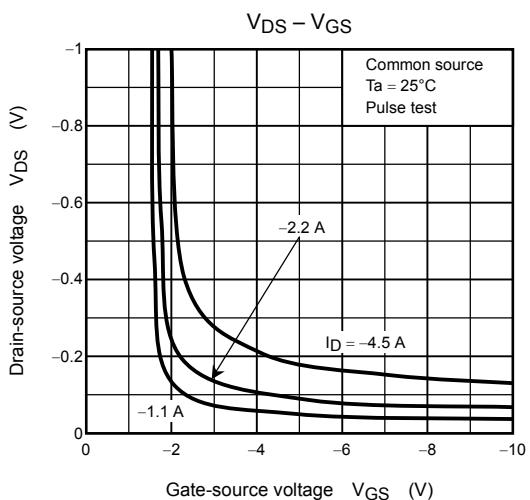
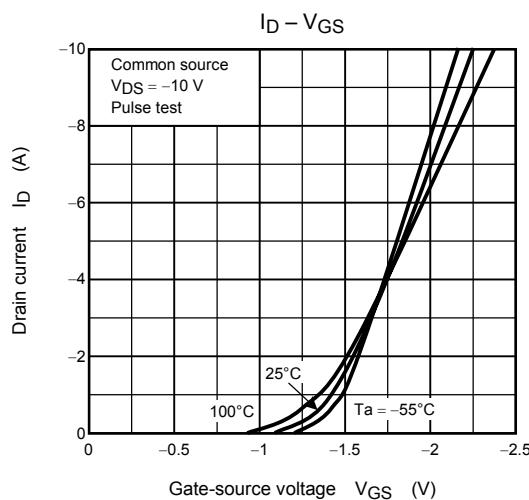
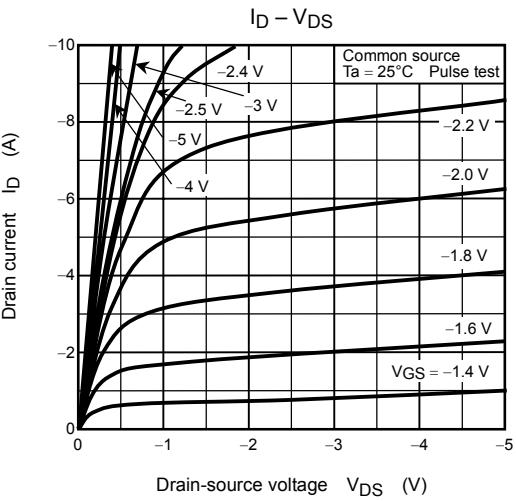
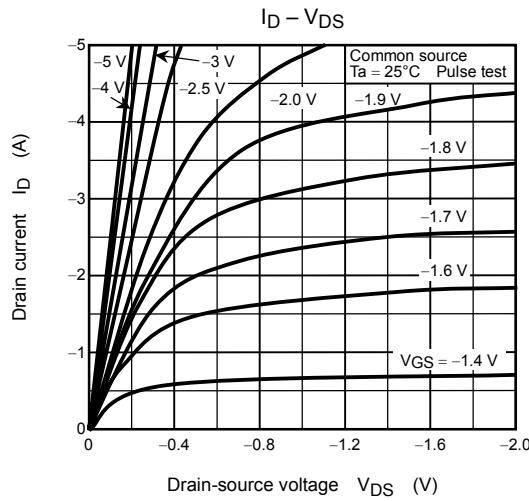
FR-4
 $25.4 \times 25.4 \times 0.8$
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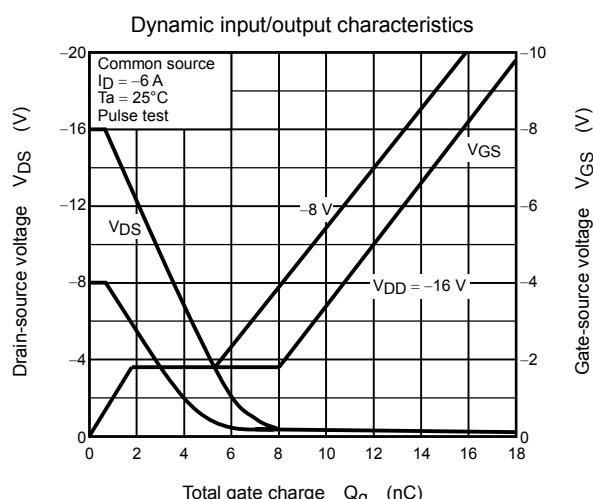
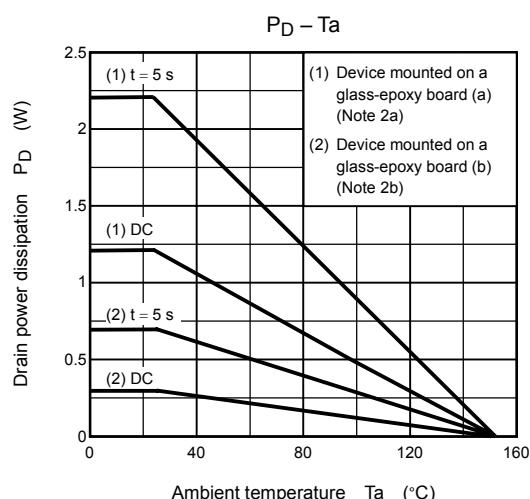
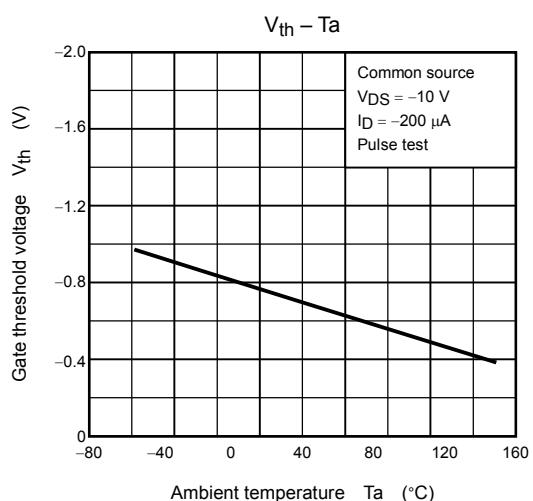
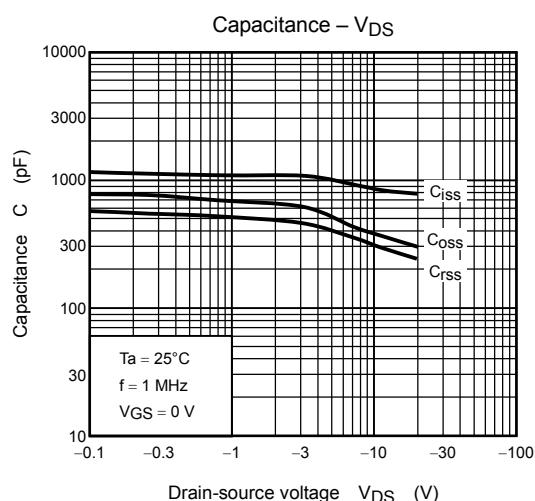
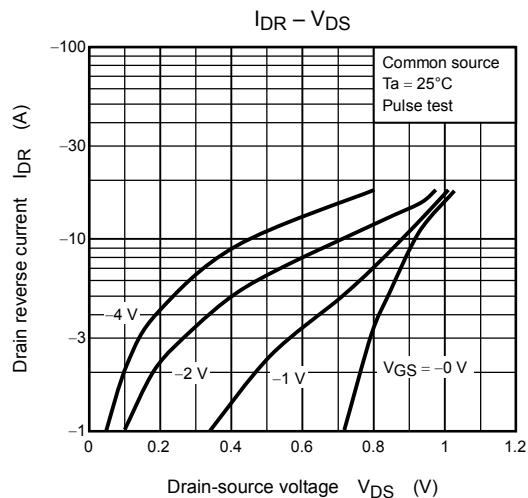
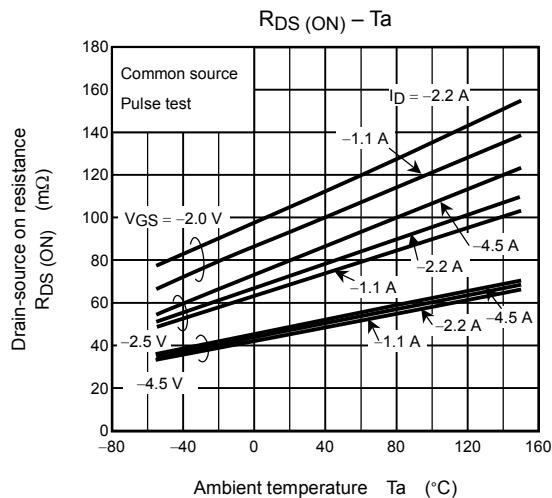
(b)

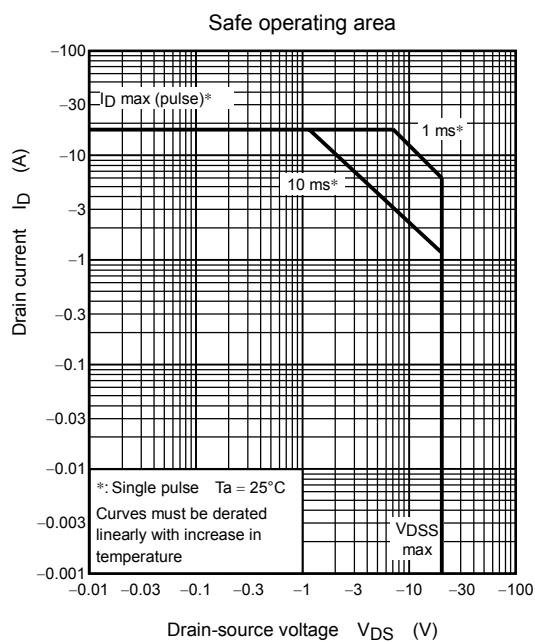
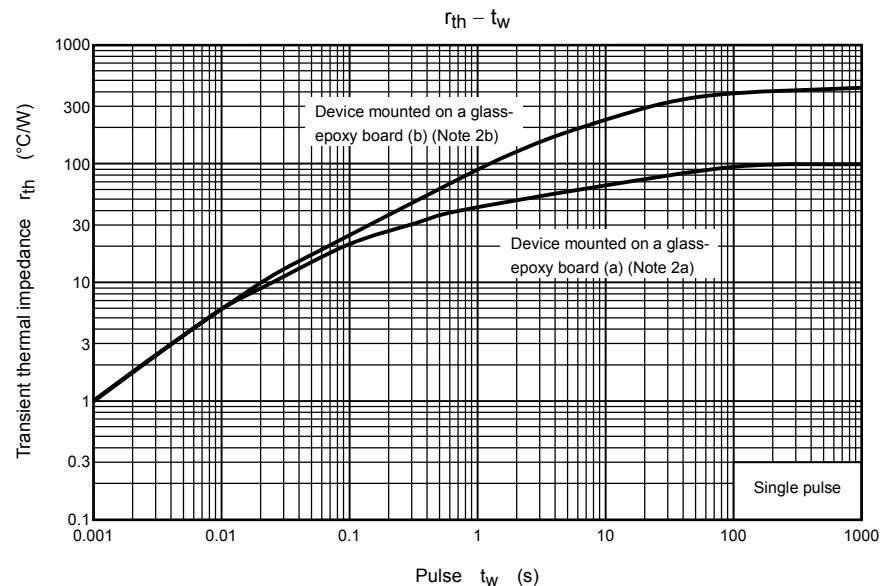
Note 3: $V_{DD} = 16\text{ V}, T_{ch} = 25^\circ\text{C}$ (initial), $L = 0.5\text{ mH}, R_G = 25\text{ }\Omega, I_{AR} = -2.25\text{ A}$

Note 4: Repetitive rating; pulse width limited by maximum channel temperature

Note 5: Black round marking “•” locates on the left lower side of parts number marking “S3A” indicates terminal No.1.







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